

**STANDARD DEPARTURE CHART -
INSTRUMENT (SID) - ICAO**

**AD 2 - EKCH
RNAV SID RWY 12 - 4
København / Kastrup**

Tabular description:

RNAV RWY 12 via KEMAX 6B

Serial Number	Path Descriptor	Waypoint Identifier	Fly-over	Course/Track °M(°T)	Magnetic Variation	Distance (NM)	Turn Direction	Altitude (ft) Upper / Lower	Speed (kt)	VPA/TCH	Navigation Specification
001	CF	SEZAC	Y	119 / (123.2)	-4.0	-	-	-	-	-	RNAV 1
002	DF	KEMAX	-	-	-4.0	-	L	-	-	-	RNAV 1

RNAV RWY 12 via SIMEG 9B

Serial Number	Path Descriptor	Waypoint Identifier	Fly-over	Course/Track °M(°T)	Magnetic Variation	Distance (NM)	Turn Direction	Altitude (ft) Upper / Lower	Speed (kt)	VPA/TCH	Navigation Specification
001	CF	SEZAC	Y	119 / (123.2)	-4.0	-	-	-	-	-	RNAV 1
002	DF	CH810	-	-	-4.0	-	-	-	-	-	RNAV 1
003	TF	SIMEG	-	126 / (130.0)	-4.0	22.5	-	-	-	-	RNAV 1

RNAV RWY 12 via SALLO 1B

Serial Number	Path Descriptor	Waypoint Identifier	Fly-over	Course/Track °M(°T)	Magnetic Variation	Distance (NM)	Turn Direction	Altitude (ft) Upper / Lower	Speed (kt)	VPA/TCH	Navigation Specification
001	CF	SEZAC	Y	119 / (123.2)	-4.0	-	-	-	-	-	RNAV 1
002	DF	CH810	-	-	-4.0	-	-	-	-	-	RNAV 1
003	TF	SALLO	-	155 / (158.8)	-4.0	37.0	R	-	-	-	RNAV 1

RNAV RWY 12 via BETUD 3B

Serial Number	Path Descriptor	Waypoint Identifier	Fly-over	Course/Track °M(°T)	Magnetic Variation	Distance (NM)	Turn Direction	Altitude (ft) Upper / Lower	Speed (kt)	VPA/TCH	Navigation Specification
001	CF	SEZAC	Y	119 / (123.2)	-4.0	-	-	-	-	-	RNAV 1
002	DF	CH811	-	-	-4.0	-	R	-	-	-	RNAV 1
003	TF	BISTA	-	242 / (245.7)	-4.0	23.0	R	-	-	-	RNAV 1
004	TF	BETUD	-	126 / (130.4)	-4.0	18.1	L	-	-	-	RNAV 1

RNAV RWY 12 via NEXEN 3B

Serial Number	Path Descriptor	Waypoint Identifier	Fly-over	Course/Track °M(°T)	Magnetic Variation	Distance (NM)	Turn Direction	Altitude (ft) Upper / Lower	Speed (kt)	VPA/TCH	Navigation Specification
001	CF	SEZAC	Y	119 / (123.2)	-4.0	-	-	-	-	-	RNAV 1
002	DF	CH811	-	-	-4.0	-	R	-	-	-	RNAV 1
003	TF	BISTA	-	242 / (245.7)	-4.0	23.0	R	-	-	-	RNAV 1
004	TF	NEXEN	-	212 / (216.3)	-4.0	29.2	L	-	-	-	RNAV 1

Changes: Editorial.